

#### ES52E9 C 1 V -16.000M

Series

RoHS Compliant (Pb-free) 5mm x 7mm Ceramic SMD

3.3Vdc Clipped Sinewave Stratum 3 TC(VC)XO

Operating Temperature Range

-20°C to +70°C

Nominal Frequency 16.000MHz • Control Voltage 1.5Vdc ±1.0Vdc

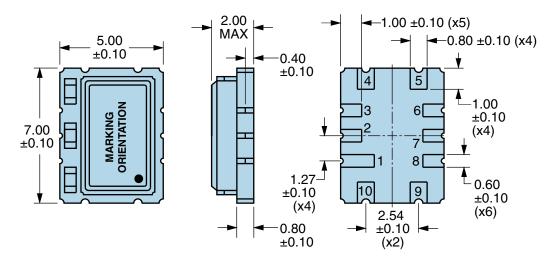
Frequency Stability -±0.28ppm Maximum

ELECTRICAL SPECIFICATIONS		
Nominal Frequency	16.000MHz	
Frequency Stability	±0.28ppm Maximum (Measured at Vdd=3.3Vdc and Vc=1.5Vdc)	
Operating Temperature Range	-20°C to +70°C	
Supply Voltage	3.3Vdc ±5%	
Total Holdover Stability	±0.37ppm Maximum (Inclusive of Frequency Stability and 24 hours aging)	
Input Current	2.0mA Maximum	
Output Voltage	0.8Vp-p Clipped Sinewave Minimum (External DC-Cut capacitor required, 150pF recommended)	
Total Frequency Tolerance	±4.6ppm Maximum (Inclusive of Frequency Tolerance, Frequency Stability, Vdd (±1%), Load (±5%), solder reflow, and 20 year aging)	
Load Drive Capability	10kOhms // 10pF	
Output Logic Type	Clipped Sinewave	
Control Voltage	1.5Vdc ±1.0Vdc	
Control Voltage Range	0.0Vdc to Vdd	
Frequency Deviation	±5ppm Minimum	
Linearity	5% Maximum	
Transfer Function	Positive Transfer Characteristic	
Input Impedance	100kOhms Minimum	
Phase Noise	-80dBc/Hz at 10Hz Offset, -115dBc/Hz at 100Hz Offset, -135dBc/Hz at 1kHz Offset, and -145dBc/Hz at >=10kHz Offset (Typical Values at 12.800MHz)	
RMS Phase Jitter	1pSec Maximum (Fj = 12kHz to 20MHz)	
Start Up Time	10mSec Maximum	
Storage Temperature Range	-40°C to +125°C	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
Fine Leak Test	MIL-STD-883, Method 1014 Condition A	
Gross Leak Test	MIL-STD-883, Method 1014 Condition C	
Mechanical Shock	MIL-STD-202, Method 213 Condition C	
Resistance to Soldering Heat	MIL-STD-202, Method 210	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010	
Vibration	MIL-STD-883, Method 2007 Condition A	



### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**

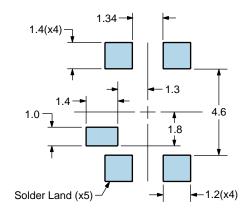


PIN	CONNECTION
1	Do Not Connect
2	Do Not Connect
3	Do Not Connect
4	Ground
5	Output
6	Do Not Connect
7	Do Not Connect
8	Do Not Connect
9	Supply Voltage
10	Voltage Control

LINE	MARKING
1	EXX.XXX  E=Ecliptek Designator  XX.XXX=Nominal  Frequency in MHz
2	XXYZZ XX=Ecliptek Manufacturing Code Y=Last Digit of the Year ZZ=Week of the Year

#### **Suggested Solder Pad Layout**

All Dimensions in Millimeters

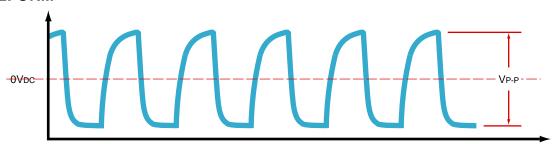


All Tolerances are ±0.1

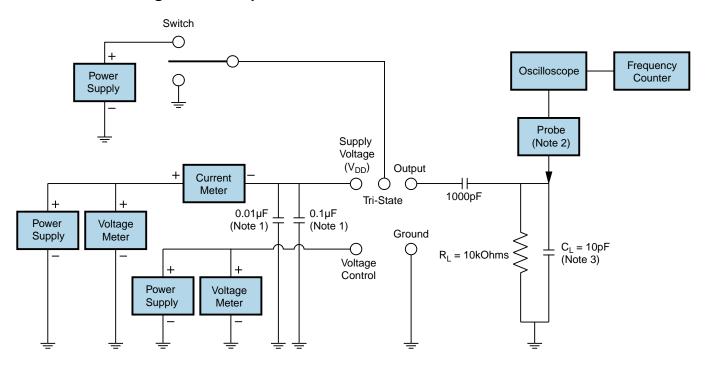


### **OUTPUT WAVEFORM**

**CLOCK OUTPUT** 



#### **Test Circuit for Voltage Control Option**



- Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value C<sub>L</sub> includes sum of all probe and fixture capacitance.



# **Recommended Solder Reflow Methods**



### **High Temperature Infrared/Convection**

T <sub>s</sub> MAX to T <sub>∟</sub> (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	150°C
- Temperature Typical (T <sub>s</sub> TYP)	175°C
- Temperature Maximum (T <sub>S</sub> MAX)	200°C
- Time (t <sub>s</sub> MIN)	60 - 180 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T <sub>P</sub> Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1



### **Recommended Solder Reflow Methods**



#### Low Temperature Infrared/Convection 230°C

T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	N/A
- Temperature Typical (T <sub>s</sub> TYP)	150°C
- Temperature Maximum (T <sub>s</sub> MAX)	N/A
- Time (t <sub>s</sub> MIN)	30 - 60 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	230°C Maximum
Target Peak Temperature (T <sub>P</sub> Target)	230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.